MOSFET - Power, Single P-Channel -40 V, 56 mΩ, -15 A

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS052P04M8L Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR–Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltag	V_{DSS}	-40	V		
Gate-to-Source Voltage	Э		V_{GS}	±16	V
Continuous Drain		T _C = 25°C	I _D	-15	Α
Current R _{0JC} (Notes 1, 2, 4)	Steady	T _C = 100°C		-10	
Power Dissipation	State	T _C = 25°C	P_{D}	23	W
R _{θJC} (Notes 1, 2)		T _C = 100°C		12	
Continuous Drain		T _A = 25°C	I _D	-5.2	Α
Current R _{θJA} (Notes 1, 3, 4)	Steady	T _A = 100°C		-3.7	
Power Dissipation	State	T _A = 25°C	P _D	2.9	W
R _{θJA} (Notes 1, 3)		T _A = 100°C		1.4	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	51	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	-19	Α
Single Pulse Drain-to-Source Avalanche Energy ($I_{L(pk)} = -1.4 \text{ A}$)			E _{AS}	54	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain) (Notes 1, 2 and 4)	$R_{\theta JC}$	6.5	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	52	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Assumes heat–sink sufficiently large to maintain constant case temperature independent of device power.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

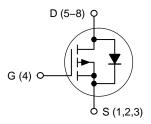


ON Semiconductor®

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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
-40 V	56 mΩ @ –10 V	–15 A
	85 mΩ @ -4.5 V	-137

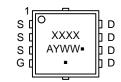
P-Channel MOSFET





CASE 511AB

MARKING DIAGRAM



XXXX = Specific Device Code A = Assembly Location

Y = Year WW = Work Week ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

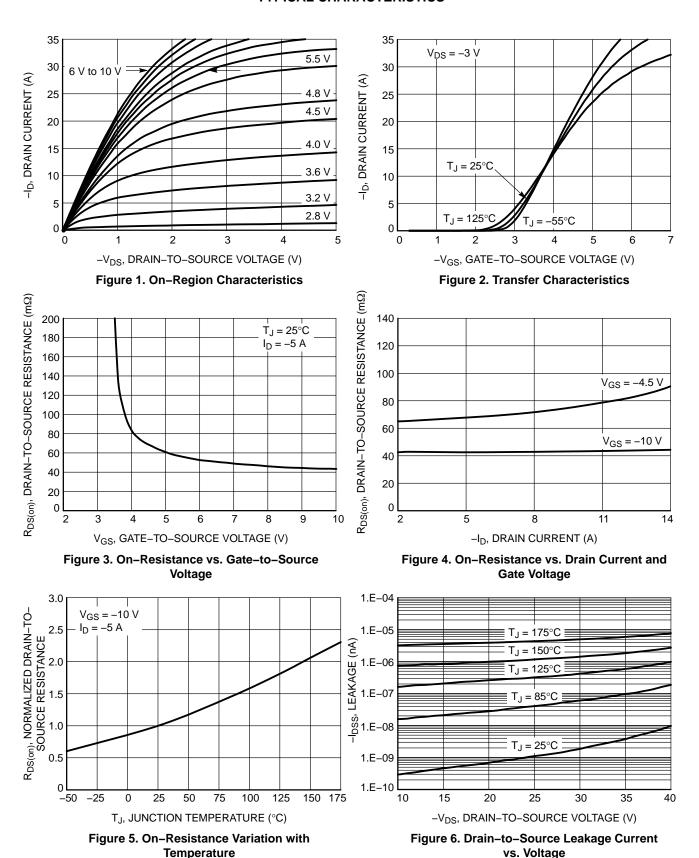
Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•			•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				23		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V},$ $V_{DS} = -40 \text{ V}$	$T_J = 25^{\circ}C$ $T_J = 125^{\circ}C$			-1.0 -1000	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$, and the second			±100	nA
ON CHARACTERISTICS (Note 5)	000	DC 7 GC					<u>I</u>
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D} =$	= –95 μΑ	-1.0		-2.4	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	GG 25.7 E	,		-5.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = -10 \text{ V}, I_D = -5 \text{ A}$			43.9	56	mΩ
		V _{GS} = -4.5 V, I _D	= -2.5 A		66.5	85	1
Forward Transconductance	9 _{FS}	$V_{DS} = -1.5 \text{ V, } I_{D}$	o = −15 A		11		S
CHARGES AND CAPACITANCES	1				1		1
Input Capacitance	C _{iss}				424		pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V, f} = 1$ $V_{DS} = -20$.0 MHz,		161		1 '
Reverse Transfer Capacitance	C _{rss}	VDS = -20	, v		9.3		1
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -2.5 \text{ V}$	20 V; I _D = -10 A		3.0		nC
		$V_{GS} = -10 \text{ V}, V_{DS} = -2$	$V_{GS} = -10 \text{ V}, V_{DS} = -20 \text{ V}; I_D = -10 \text{ A}$		6.3		1
Threshold Gate Charge	Q _{G(TH)}				0.8		Ī
Gate-to-Source Charge	Q _{GS}	Vcs = -10 V. Vn	e = -20 V		1.6		Ī
Gate-to-Drain Charge	Q_{GD}	$V_{GS} = -10 \text{ V}, V_{DS}$ $I_{D} = -10$	Α		1.0		Ī
Plateau Voltage	V_{GP}	1			3.7		V
SWITCHING CHARACTERISTICS, Vo	_{SS} = -4.5 V (Not	te 6)			1		1
Turn-On Delay Time	t _{d(on)}				9.8		ns
Rise Time	t _r	$V_{GS} = -4.5 \text{ V}, V_{DS}$	e = -20 V		28.5		
Turn-Off Delay Time	t _{d(off)}	$I_D = -10 \text{ A}, R_G$	$= 2.5 \Omega$		10.9		Ī
Fall Time	t _f	1			6.1		Ī
DRAIN-SOURCE DIODE CHARACTE	RISTICS				•	•	
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V,$ $I_{S} = -5 A$	T _J = 25°C		-0.88	-1.25	V
Devere December Torre			T _J = 125°C		-0.77		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = -10 \text{ A}$			21		ns
Charge Time	t _a				12.2		-
Discharge Time	t _b				8.8		_
Reverse Recovery Charge	Q_{RR}				9.1	52	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width $\leq 300~\mu$ s, Duty Cycle $\leq 2\%$.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

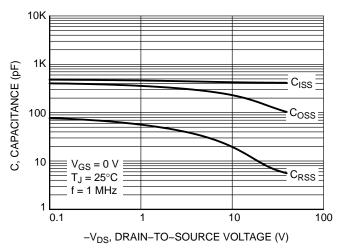


Figure 7. Capacitance Variation

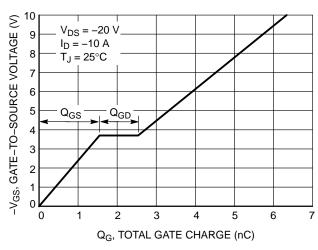


Figure 8. Gate-to-Source vs. Total Charge

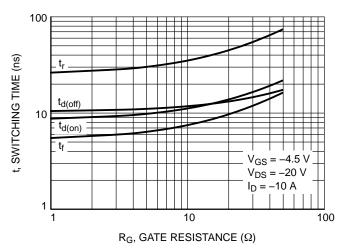


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

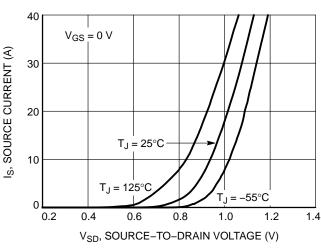


Figure 10. Diode Forward Voltage vs. Current

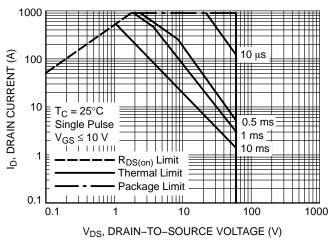


Figure 11. Maximum Rated Forward Biased Safe Operating Area

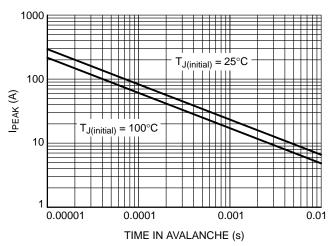


Figure 12. Maximum Drain Current vs. Time in Avalanche

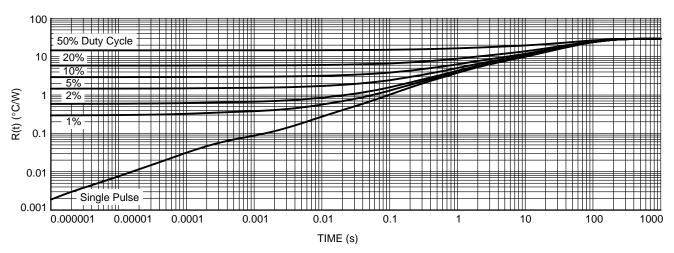


Figure 13. Thermal Response

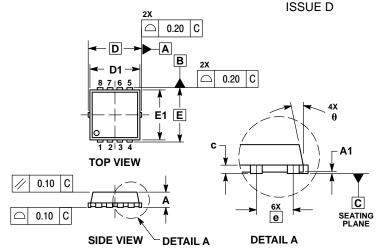
DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFS052P04M8LTAG	052M	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFWS052P04M8LTAG	052W	WDFN8 (Pb-Free, Wettable Flank)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

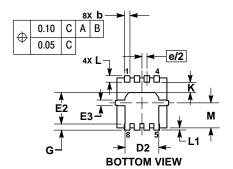
PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB

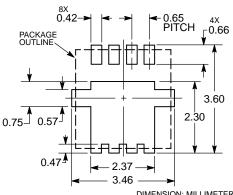


- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0.130 BSC		
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E	3.30 BSC			0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			0.026 BSC		
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
M	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °



SOLDERING FOOTPRINT*



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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